## SHALLOW AND DEEP CORE LEVEL IONIC FRAGMENTATION OF THE CCl<sub>4</sub> MOLECULE

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Carbon tetrachloride, CCl<sub>4</sub>, is a volatile compound with several important technological applications, being for instance used as an etching agent in microelectronics. In addition, the CCl<sub>4</sub> molecule pollutes atmosphere harmfully and has been related to the so-called greenhouse effect [4]. Several studies have been dedicated to the photoabsorption spectrum of the CCl<sub>4</sub> molecule, both in the valence and inner-shell regions [1-4]. This molecule presents a tetrahedral symmetry (T<sub>d</sub> point group).

In this work we report on the ionic fragmentation of the CCl<sub>4</sub> molecule following valence, and core level photoexcitation, using tunable synchrotron radiation as exciting source. Branching ratios for the ionic fragments have been determined, as a function of the incident photon energy around the valence, Cl 2p edge (~200 eV)., C 1s continuum (~ 300 eV), and Cl 1s (~ 2800 eV) regions.

The valence and shallow core levels (Cl 2p and C 1s) measurements were performed at the Center for Advanced Microstructures and Devices (CAMD), Louisiana, USA. The experimental set up has been described recently [5]. Basically, light from a toroidal grating monochromator (TGM) beamline intersected an effusive gaseous sample inside a high vacuum chamber, with base pressure in the 10<sup>-8</sup> torr range. PEPICO and PIPICO data were determined as a function of the photon energy using a time-of-flight mass spectrometer.

The second part of this work (deep core level ionization) was performed using x-ray synchrotron radiation from beamline 9.3.1 at the Advanced Light Source (ALS) in Berkeley, California. 9.3.1 is a bending magnet beamline covering 2-6 keV photon-energy range. This beamline provides a flux of  $10^{11}$  photons s<sup>-1</sup> in a bandpass  $\leq 0.5$  eV. Photon-energy calibration was achieved by scanning the monochromator through the Cl K-edge region while monitoring the total-ion yield . The photon-energy was determined with 0.2 eV accuracy. Figs. 1 and 2 show the PEPICO mass spectra of CCl<sub>4</sub> around the Cl 2p and Cl 1s edges.

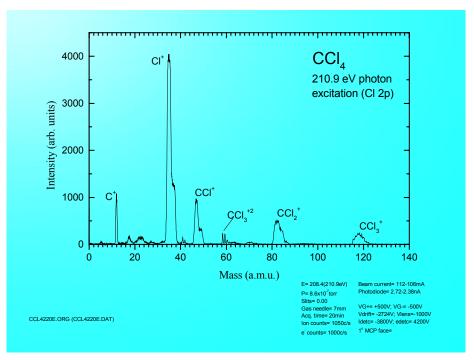


Fig 1. - Mass Spectrum of CCl<sub>4</sub> molecule near the Cl 2p edge (210 eV).

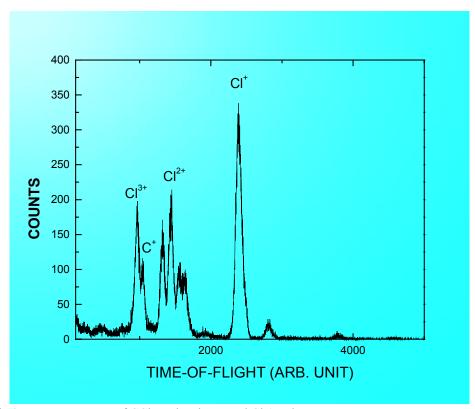


Fig.2 – Mass spectrum of CCl<sub>4</sub> molecule around Cl 1s edge.

There is no evidence for stable  $CCl_4^+$  ion in the energy range studied in this work in accordance with earlier studies using electron impact technique [6, 7]. The first evidence for metastable  $CCl_4^+$  ion was given by Drewello *et al.* [8], with lifetimes in the order of  $10^{-5}$  s. According to Kaufmann *et al.* [8], the  $CCl_4^+$  is not observed because the excitation of the carbon tetrachlorine molecule occurs into a repulse excited state of neutral  $CCl_4$  which dissociates into  $Cl_4^+$  and  $Cl_4^+$  into  $CCl_3^+$  ion. Leiter *et. al.* [6] observed the metastable dissociation of  $CCl_4^{+*}$  into  $CCl_3^+$  and  $Cl_4^+$  are postulation of dissociation of neutral  $CCl_4^+$  prior to ionization.

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